ARMI | MBH

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Certified Reference Material — Certificate of Analysis

ISO 17034:2016 | ISO/IEC 17025:2017 | ISO 9001:2015

Product ID: MBH-91X S63P-22

Product Description: Lead/Tin Solder Binary Alloy

Revision No.: 000
Revision Date: 09/08/2022

Description and Intended Use: This **Certified Reference Material** is covered under the scope of accreditation to **ISO 17034** by LGC Standards - Manchester, NH. As an ISO 17034 certified reference material, appropriate use of this material will fulfill the certified reference material and traceability requirements for use in **ISO 17025** accredited laboratories. This CRM may come in the form of a solid disk, or chips. The intended use of this CRM may include, but is not limited to, the calibration of instruments and the validation of analytical methods.

Certified Values listed in wt.% with associated uncertainties

Ag	**0.0046**	±0.0004	**Cu**	**0.0016**	±0.0003	**In**	**0.0044**	±0.0006	**Sb**	**0.018**	± 0.004
Bi	**0.0048**	±0.0008	**Fe**	**0.0020**	±0.0004	**Ni**	**0.0006**	±0.0003	**Sn**	**62.2**	± 0.2

Indicative Values listed in ppm

As	(8)	Au	(4)	Ca	(2410)	Cd	(2)	Hg	(34)
Mg	(6)	Pb	Balance	Se	(52)	Te	(64)	Zn	(16)

Homogeneity and Uncertainty: "Uncertainty" values, as reported adjacent to certified concentration values, are based on a 95% Confidence Interval. These estimated uncertainties include the combined effects of method imprecision, material inhomogeneity, and any bias between methods. Homogeneity data from experimental XRF results are reflected in both the overall statistics and certified data. Homogeneity samples are selected by a systematic sampling procedure. The number of samples may be determined by equation 1, where N_{prod} is the number of units produced and N_{min} is the number of samples used for homogeneity testing. These samples are arranged in a simple randomized design such that each sample is analyzed multiple times by XRF. Homogeneity may also be determined within sample using an applied version of ASTM E826. A single factor ANOVA is used to calculated uncertainty due to inhomogeneity (U_{hom}). Uncertainty of the material is calculated by equation 2, where H=U_{hom}, S= Standard deviation, t= t-value at 95% CI, and n= number of observations.

$$1.\ N_{MIN} = \max\left(10, \sqrt[3]{N_{PROD}}\right) \qquad 2.\ U_{CRM} = \frac{\sqrt{H^2 + S^2}}{\sqrt{n}} * t$$

Certification Laboratories: Much of the analytical work performed to assess this material has been carried out by laboratories with proven competence, as indicated by their accreditation to ISO 17025. It is an implicit requirement for this accreditation that analytical work should be performed with due traceability, via an unbroken chain of comparisons, each with stated uncertainty, to primary standards such as the mole, or to nationally- or internationally-recognised reference materials. Of the individual results herein, some have traceability (to the mole) via primary analytical methods. Some are traceable to substances of known stoichiometry. Most have traceability via commercial solutions. Furthermore, some results have additional traceability to NIST standards, as part of the analytical calibration or process control.

- AIM - Montreal, QC, Canada
- Alpha Assembly Solutions - Altoona, PA
- Dirats Laboratories - Westfield, MA
- Lukasiewicz Instytut Metali Niezelaznych - Gilwice, Poland
- IMR Test Labs - Lansing, NY
- Inppamet Anodos - Calama, Chile
- LGC Standards - Manchester, NH
- Scrooby's Laboratory Service - Benoni, South Africa
- SGS MSi - Melrose Park, IL
- Sheffield Assay Office - Sheffield, England

Instructions for Use: The test surface is on the opposite side of the labeled surface, which includes the material identification. This material is individually chill cast per piece. This manner of casting can cause the formation of inhomogeneous segregates in the upper, engraved portion of the disk. Therefore, the certification information above is not applicable to within 3mm of the engraved surface. Each packaged disk has been prepared by finishing the test surface using a lathe. The user must determine the correct surface preparation procedure for each analytical technique. The user is cautioned to use care when either resurfacing the disk or performing additional polishing, as these processes may contaminate the surface. The minimum sample size for chips should be individually evaluated based on the analytical technique used; this would typically be greater than 0.1 grams. The material should be stored in a cool, dry location when not in use.
Chips are not recommended for gas analysis.

Period of Validity: The certification of this material is valid indefinitely, within the uncertainty specified, provided the material is handled and stored in accordance with the instructions stated on this certificate. The certification is nullified if the material is damaged, contaminated, otherwise modified, or used in a manner for which it was not intended.

Chuck Goudreau, Certifying Officer

8 September 2022
Certification Date

ACCREDITED

ISO 17034 Accredited: Reference Materials Producer, Certificate # 2848.02
ISO/IEC 17025 Accredited: Chemical Testing, Certificate # 2848.01

Conditions of Sale and Supply: All CRMs & RMs sold are subject to applicable LGC Standard Terms and Conditions of Sale.

LGC

The following data represents all pertinent information reported as it applies to the chemical characterization of this material.

	Ag	As	Au	Bi	Ca	Cd	Co	Cu	Fe	Hg	In	Mg	Ni
1	0.0032	0.00012	0.0002	0.0025	0.003	0.00007	<0.0002	0.0013	0.0014	0.0034	0.0036	0.0006	0.0003
2	0.0040	0.0007	0.0006	0.0039	<0.0002	0.0002	<0.0005	0.0013	0.0015	<0.0002	0.0038		0.0004
3	0.0043	0.00075	<0.0005	0.0040	<0.001	0.00021	<0.001	0.0014	0.0016	<0.0005	0.0040		0.00047
4	0.0045	0.0017	<0.0010	0.0040	<0.005	<0.0001	<0.002	0.0015	0.0018		0.0041		0.0005
5	0.0046	<0.0005	<0.005	0.0046	<0.005	<0.0002	<0.002	0.0016	0.0021		0.0043		0.0008
6	0.0046	<0.0005		0.0049		<0.0005	<0.005	0.0018	0.0022		0.0044		0.001
7	0.0046	<0.001		0.0052		<0.001		0.0019	0.0024		0.0049		<0.001
8	0.0047	<0.002		0.0053		<0.002		0.0024	0.0027		0.0060		<0.002
9	0.0049	<0.002		0.0058		<0.002		<0.002	0.00270612		<0.005		<0.002
10	0.0050	<0.005		0.0060		<0.005		<0.005	<0.002				<0.005
11	0.0052			0.0069					<0.002				
12	0.0055			<0.005									
Mean	0.0046	0.0008	0.0004	0.0048	0.0030	0.0002		0.0016	0.0020	0.0034	0.0044	0.0006	0.0006
STDV	0.0006			0.0012				0.0004	0.0005		0.0008		0.0003
Certified	0.0046	(0.0008)	(0.0004)	0.0048	(0.003)	(0.0002)		0.0016	0.0020	(0.0034)	0.0044	(0.0006)	0.0006
U_{CRM}	0.0004			0.0008				0.0003	0.0004		0.0006		0.0003
Methods	I,O,IM,A,X	I,O,IM,X	IM,O,I	I,O,IM,A,X	I,X	I,O,IM,A,X	I,X	I,O,IM,A	I,O,IM,A,X	I	I,O	I	I,O,A,X

	Pb	Sb	Se	Sn	Te	Zn
1	35.0	0.0119	0.0052	61.794	0.0019	0.0004
2	35.7	0.0122	<0.0005	62.080	0.0038	0.0004
3	36.2	0.0142	<0.0005	62.120	0.0083	0.00113
4	37.5	0.0166	<0.001	62.159	0.009	0.003
5	37.6	0.0205	<0.002	62.200	0.009	0.003
6	37.7	0.0211	<0.002	62.220	<0.0005	<0.0005
7		0.021378902	<0.005	62.390	<0.001	<0.0005
8		0.0232		62.412	<0.005	<0.001
9		<0.005				<0.005
10						
11						
12						
Mean	36.63	0.0176	0.0052	62.17	0.0064	0.0016
STDV		0.0045		0.1936		
Certified	(36.63)	0.018	(0.0052)	62.2	(0.0064)	(0.0016)
U_{CRM}		0.004		0.2		
Methods	I,W,A	I,O,IM,A	I,X	W,I,A,O,X	IM,I,X	I,O,X

Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, IM=ICP-MS, D = DC Arc, O = AES, X = XRF, G = GDAES or GDMS, H = Hollow Cathode AES